

<b>Notice of References Cited</b>	Application/Control No. 10/059,182		Applicant(s)/Patent Under Reexamination SUURONEN ET AL.	
	Examiner Yin-Chen Shaw		Art Unit 2439	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,069,432	06-2006	Tighe et al.	713/151
*	B	US-7,047,561	05-2006	Lee, Michael C. G.	726/12
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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